FDP6670AL/FDB6670AL

FDP6670AL/FDB6670AL N-Channel Logic Level PowerTrench^o MOSFET

General Description

G

D

 $R_{\theta JA}$

S

This N-Channel Logic Level MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS(ON)}}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

It has been optimized for low gate charge, low $R_{\text{DS}(\text{ON})}$ and fast switching speed.

Features

- 80 A, 30 V $R_{DS(ON)} = 6.5 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 8.5 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- Critical DC electrical parameters specified at elevated temperature
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- 175°C maximum junction temperature rating

62.5



TO-220

FDP Series

Symbol	Parameter	Ratings	Units	
V _{DSS}	Drain-Source Voltage	30	V	
V _{GSS}	Gate-Source Voltage	± 20	V	
ID	Drain Current – Continuous (Note 1)	80	A	
	– Pulsed (Note 1)	240		
PD	Total Power Dissipation @ $T_c = 25^{\circ}C$	68	W	
	Derate above 25°C	0.45	W/°C	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-65 to +175	°C	
Therma	I Characteristics			
R _{θJC}	Thermal Resistance, Junction-to-Case	2.2	°C/W	

D

TO-263AB

FDB Series

Package Marking and Ordering Information

Thermal Resistance, Junction-to-Ambient

Device Marking	Device	Reel Size	Tape width	Quantity
FDB6670AL	FDB6670AL	13"	24mm	800 units
FDP6670AL	FDP6670AL	Tube	n/a	45

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FDP6670AL/FDB6670AL Rev D(W)

°C/W



Symbol	Parameter	Test Conditions	Min	Tvp	Max	Units
				- 76		•
Drain-Sc	Durce Avalanche Ratings (Note	1)			111	
VVDSS	Avalanche Energy	$V_{DD} = 15 V$, $I_D = 60 A$			114	mJ
I _{AR}	Maximum Drain-Source Avalanche Current				80	A
Off Char	acteristics					
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_D = 250 \mu\text{A}$	30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		24		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μA
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			± 100	nA
On Char		•				
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1	1.9	3	V
$\Delta V_{GS(th)}$ $\Delta T_{.1}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		-5		mV/°C
R _{DS(on)}	Static Drain–Source On– Resistance			5.2 6.5 7.2	6.5 8.5 9.7	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$	80			Α
g _{ES}	Forward Transconductance	$V_{DS} = 10V$, $I_D = 40 A$		115		S
Dynamic	Characteristics			1		1
Ciss	Input Capacitance	$V_{DC} = 15 V$ $V_{CC} = 0 V$		2440		pF
Coss	Output Capacitance	f = 1.0 MHz		580		pF
C _{rss}	Reverse Transfer Capacitance			250		pF
R _G	Gate Resistance	V _{GS} = 15 mV, f = 1.0 MHz		1.4		Ω
Switchin		•				
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 10V, I_D = 1 A,$		13	23	ns
t _r	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		13	23	ns
t _{d(off)}	Turn–Off Delay Time	1		42	68	ns
t _f	Turn–Off Fall Time	1		15	27	ns
Q _a	Total Gate Charge	$V_{DS} = 15 V$, $I_D = 40 A$,		24	33	nC
Q _{qs}	Gate–Source Charge	$V_{GS} = 5 V$		7		nC
Q _{gd}	Gate-Drain Charge	1		9		nC
Drain_S	ource Diode Characteristics	and Maximum Ratings				
l _s	Maximum Continuous Drain–Source	Diode Forward Current			80	А
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 40 A$ (Note 1)		0.9	1.3	V
t _{rr}	Diode Reverse Recovery Time	$I_{F} = 40 \text{ A},$		34		nS
	Diada Davaraa Daaayary Charga	d _{iF} /d _t = 100 A/μs		24		

1. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

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FDP6670AL/FDB6670AL Rev D(W)



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